



P-Channel 20 V (D-S) MOSFET



COMPLIANT

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}\left(\Omega\right)$	$I_D(A)^d$ $Q_g(Ty)$				
- 20	0.012 at V _{GS} = - 4.5 V	- 12	36 nC			
- 20	$0.0145 \text{at V}_{GS} = -2.5 \text{V}$	- 11	30 110			

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SO-8 D 3 D D

Top View

P-Channel MOSFET

FEATURES

- DT-Trench Power MOSFET
- 100 % R_g Tested
- 100 % UIS Tested

APPLICATIONS

- Adapter switch
- · Load switch
- DC/DC converters
- High speed switching
- Power management in battery-operated, mobile and wearable devices

ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C, unless otherwise noted)					
PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-source voltage		V _{DS}	-20	V	
Gate-source voltage		V_{GS}	± 12	v	
Continuous drain current (T _J = 150 °C)	T _C = 25 °C		-12 ^e		
	T _C = 70 °C	1 , [-11		
	T _A =25 °C	l _D	-5.3 ^{b, c}		
	T _A = 70 °C	1	-4.5 ^{b, c}	A	
Pulsed drain current (t = 100 μs)		I _{DM}	-48 ^a		
Continuous source-drain diode current	T _C = 25 °C	1	-12		
	T _A = 70 °C	l _S	-5.5 ^{b, c}		
Maximum power dissipation	T _C = 25 °C	3.0	3.0		
	T _C = 70 °C	T 5 [1.92	14/	
	T _A = 25 °C	P _D	1.7 b, c	W	
	T _A = 70 °C	1	1.1 ^{b, c}		
Operating junction and storage temperature range		T _J , T _{stg}	-55 to +150	**	
Soldering recommendations (peak temperature)			260	°C	

THERMAL RESISTANCE RATINGS							
PARAMETER	SYMBOL	TYPICAL	MAXIMUM	UNIT			
Maximum junction-to-ambient b, d	t ≤ 10 s	R _{thJA}	40	50	°C/W		
Maximum junction-to-foot (drain)	Steady state	R_{thJF}	15	20			

Notes

- a. Package limited
- b. Surface mounted on 1" x 1" FR4 board
- d. Maximum under steady state conditions is 100 °C/W
- e. $T_C = 25$ °C





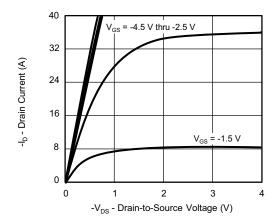
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-source breakdown voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	-20	-	-	V	
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	J 050 A	-	-11	-	mV/°C	
V _{GS(th)} temperature coefficient	$\Delta V_{GS(th)}/T_J$	I _D = -250 μA	-	23.5	-		
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = -250 \mu A$	-0.4	-	-1.2	V	
Gate-source leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$	-	-	± 100	nA	
Zono del college delle const	I _{DSS}	V _{DS} = -16 V, V _{GS} = 0 V	-	-	-1	μА	
Zero gate voltage drain current		V _{DS} = -16 V, V _{GS} = 0 V, T _J = 55 °C	-	-	-10		
On-state drain current ^a	I _{D(on)}	$V_{DS} \le -5 \text{ V}, V_{GS} = 0 \text{ V}$	-12	-	-	Α	
Drain-source on-state resistance ^a	R _{DS(on)}	$V_{GS} = -4.5 \text{ V}, I_D = -10 \text{ A}$	-	0.012	0.015	Ω	
	ייטS(on)	$V_{GS} = -2.5 \text{ V}, I_D = -8 \text{ A}$		0.0145	0.020		
Forward transconductance ^a	9 _{fs}	$V_{DS} = -10 \text{ V}, I_{D} = -10 \text{ A}$	-	35	-	S	
Dynamic ^b							
Input capacitance	C _{iss}		-	2055	-	pF	
Output capacitance	C _{oss}	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	686	-		
Reverse transfer capacitance	C _{rss}		-	135	-		
Total gate charge	Q_g		-	36	=		
Gate-source charge	Q _{gs}	V_{DS} = -10 V, V_{GS} = -4.5 V, I_D = -10 A	-	6.7	-	nC	
Gate-drain charge	Q _{gd}		-	13	-		
Gate resistance	R _g	f = 1 MHz	-	5	-	Ω	
Turn-on delay time	t _{d(on)}		-	61	-		
Rise time	t _r	V_{DD} = -10 V, R_L = 2 Ω , I_D \cong -10 A,	-	35	-	ns	
Turn-off delay time	t _{d(off)}	V_{GEN} = -4.5 V, R_g = 1 Ω	-	110	-	115	
Fall time	t _f		-	203	-		
Drain-Source Body Diode Characteristi	cs						
Continuous source-drain diode current	I _S	T _C = 25 °C -			-12		
Pulse diode forward current	I _{SM}				-48	Α	
Body diode voltage	V_{SD}	I _S = -1 A, V _{GS} = 0 V	-	-0.6	-1.2	V	
Body diode reverse recovery time	t _{rr}		-	51	-	ns	
Body diode reverse recovery charge Q _{rr}		I FA dI/d+ 100 A/:- T 05 00	-	68	-	nC	
Reverse recovery fall time	t _a	$I_F = -5 \text{ A, dl/dt} = 100 \text{ A/}\mu\text{s, T}_J = 25 °\text{C}$		22	-		
Reverse recovery rise time	t _b		-	39	-	ns	

- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%$
- b. Guaranteed by design, not subject to production testing

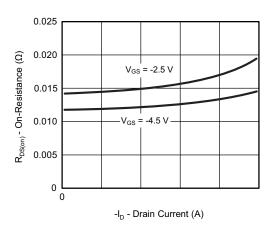
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



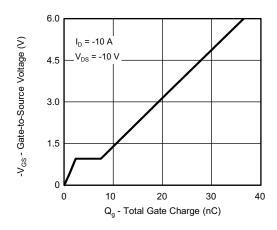
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



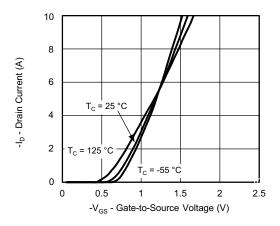
Output Characteristics



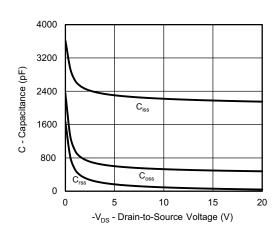
On-Resistance vs. Drain Current and Gate Voltage



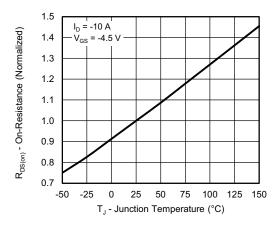
Gate Charge



Transfer Characteristics



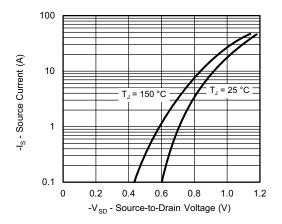
Capacitance



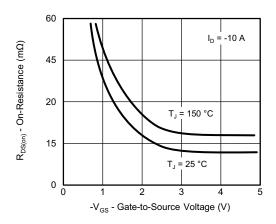
On-Resistance vs. Junction Temperature



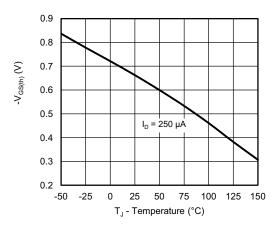
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



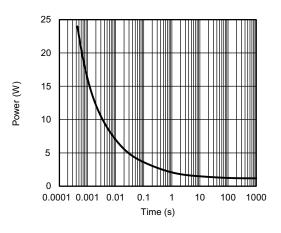
Source-Drain Diode Forward Voltage



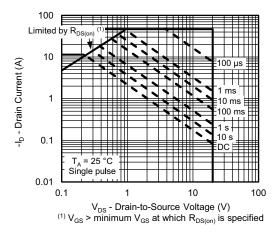
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



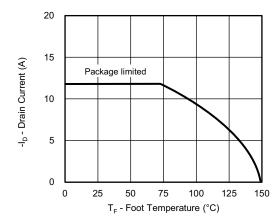
Single Pulse Power, Junction-to-Ambient

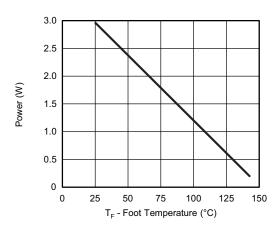


Safe Operating Area, Junction-to-Ambient



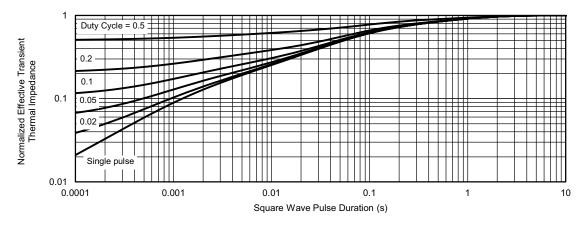
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





Current Derating a

Power, Junction-to-Foot



Normalized Thermal Transient Impedance, Junction-to-Foot

Note

a. The power dissipation P_D is based on T_J max. = 25 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





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